

Notice of References Cited	Application/Control No. 10/580,856		Applicant(s)/Patent Under Reexamination DEFAYE ET AL.	
	Examiner Jonathan S. Lau		Art Unit 1623	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,684,169	11-1997	Hamada et al.	549/510
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Ortiz-Mellet et al. Chem. Eur. J. 2002, 8(9), p1982-1990.
	V	Kotter et al. J. Chem. Soc., Perkin Trans. 1, 1998, p2193-2200.
	W	Charbonnier et al. Tetrahedron Letters, 1999, 40, p6581-6583.
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.